World Academy of Science, Engineering and Technology International Journal of Mathematical and Computational Sciences Vol:8, No:11, 2014

Compressive Stresses near Crack Tip Induced by Thermo-Electric Field

Authors: Thomas Jin-Chee Liu

Abstract: In this paper, the thermo-electro-structural coupled-field in a cracked metal plate is studied using the finite element analysis. From the computational results, the compressive stresses reveal near the crack tip. This conclusion agrees with the past reference. Furthermore, the compressive condition can retard and stop the crack growth during the Joule heating process.

Keywords: compressive stress, crack tip, Joule heating, finite element

Conference Title: ICCSO 2014: International Conference on Computational Sciences and Optimization

Conference Location: Kyoto, Japan Conference Dates: November 13-14, 2014